



Test Report for Part 15

Report number: STD-FCC-05015

Type of EUT: 17" TFT LCD Monitor

Model number: DS174
Family Model

Applicant: DAYSYSTEM CO., LTD.

Applied standards: FCC Part 15 Subpart B(Class B)

The above mentioned EUT had been tested by EMC Laboratory of Standard Engineering Company in order to confirm the compliance with the requirements of FCC rules and this test was executed in accordance with the measurement method specified in ANSI C63.4-2001

I hereby certify that the accuracy of test-data is true and correct with my best knowledge and belief. Also I prove this measurement was performed by qualified person,

Date of tested: 2005-07-27

Date of Issued 2005-08-01

Tested by: 
SS Seo / Test Engineer

Approved by 
HD Park / Manager



Contents

1. General information

- 1.1 Product information
- 1.2 Client information

2. Information of EMC Laboratory

3. Procedure of measurement

- 3.1 Conducted emission
 - 3.1.1 Configuration of measurement
 - 3.1.2 Detector function selection and bandwidth
 - 3.1.3 Frequency range to be scanned
 - 3.1.4 Line impedance stabilization network (LISN)
- 3.2 Radiated emission
 - 3.2.1 Configuration of measurement
 - 3.2.2 Detector function selection and bandwidth
- 3.3 Method of calculation

4. Environment of measurement

- 4.1 Condition of environment
- 4.2 Measurement uncertainty
- 4.3 List of Test equipments
- 4.4 List of peripherals and cables
- 4.5 Configuration of EUT

5. Result of measurement

- 5.1 Conducted emission
 - 5.1.1 Test data
 - 5.1.2 Result
- 5.2 Radiated emission
 - 5.2.1 Test data
 - 5.2.2 Result

6. Attachment

- 6.1 Sample Label
- 6.2 Photographs of Set-up
- 6.3 Photographs of EUT
- 6.4 Conducted emission data
- 6.5 Block Diagram/Circuit
- 6.6 User's Manual



1. General Information

1.1 Product information

Description of EUT : 17" TFT LCD Monitor

Model number : DS174

Family Model :

Specification : Adaptor Input : AC100~240V, 1.2A, 50/60Hz
Adaptor Output : DC12V, 3.5A, 35W

Applied Standard : FCC Part 15 subpart B (Class B)

Test method : ANSI C63.4 - 2001

1.2 Client information

Applicant : DAYSYSTEM CO., LTD.

Address : #459-21, Gasan-Dong, Gumchun-Gu, Seoul, Korea

Phone No. : +82-2-3281-6470

Fax. No. : +82-2-3281-6473

Contact person : SangJune Kim / Vice President

Manufacturer : DAYSYSTEM CO., LTD.

Address : #459-21, Gasan-Dong, Gumchun-Gu, Seoul, Korea

Phone No.: +82-2-3281-6470

Fax. No.: +82-2-3281-6473



2. Information of EMC Laboratory

Name of test laboratory

Standard Engineering Co., Ltd.

Location

377-11 Sinjang-Ri, Eumam-Myeon, Seosan-Si Chungnam, Korea

Phone No. : +82-41-663-9436~7

Fax. No. : +82-41-663-9434

FCC Filing Number : 284057

Environment of Laboratory

This location can keep accuracy in measuring more than anywhere because surrounding noise ambient is low and silent excellently to be suitable in EMI's measuring.

Map



3. Procedure of measurement

3.1 Conducted emissions

3.1.1 Configuration of measurement

This measurement executed in shield-room and EUT was tested on 0.8m height wooden table located on the floor with 0.1m distance from the reference ground plane.

EUT's rear part had a distance from VCP(Vertical Conducted Plane) with 0.4m length and LISN placed on the grounded plane with 1m distance from EUT's side part .

Excess power cord and cables fixed in bundle style of 30~40cm length with non-inductive material, and power line was connected to power source through LISN to detect maximum EMI without external RFI from aux. instruments.

For the measurement, 'H' scroll pattern was applied to the EUT with maximum resolution (1280x1024) in order to detect maximum electromagnetic disturbance from the EUT.

Measuring equipments and EUT confirmed that warming-up was performed during enough time and calibration of antenna as well as calibration of measuring equipment also completed beforehand.

This measurement was performed on condition of worst-case emission.

3.1.2 Detector function selection and bandwidth

During conducted emission measurement, a radio noise meter that has a CISPR quasi-peak detector with 10 kHz IF bandwidth of 6 dB was utilized.

3.1.3 Frequency range to be scanned

For conducted emissions measurement, frequency range of 150 kHz to 30 MHz included, was investigated.

3.1.4 Line impedance stabilization network (LISN)

A LISN with characteristics that conform to the requirements of ANSI C63.4-1992 was used for the measurement of conducted power-line radio noise; (50 micro-henries / 50 ohms).

Chassis and earth-points for grounding of the LISN were earth-grounded.

3.2 Radiated Emissions

3.2.1 Configuration of measurement

Preliminary measurement was performed in 3 meter semi-anechoic chamber to detect correct EMI frequency. For detecting the EMI frequency in semi-anechoic chamber, TRILOG antenna used on 30-1000MHz band.

Final measurement was executed at 3 meters OATS(Open Area Test Site) using Quasi-peak detector and TRILOG antenna.

EUT was placed on 0.8m height wooden table located on the floor with 0.1m distance from the reference ground plane.

Excess power cord and other excess cables fixed in bundle style of 30~40cm length with non-inductive material to detect maximum EMI emission from EUT.

For the measurement, 'H' scroll pattern was applied to the EUT with maximum resolution (1280x1024) in order to detect maximum electromagnetic disturbance from the EUT.

Measuring equipments and EUT confirmed that warming-up was performed during enough time and calibration of antenna as well as calibration of measuring equipment also completed beforehand.

Measurement antenna height was varied 1 to 4 meters and set position in both horizontal and vertical plane to search maximum EMI emission frequency.

3.2.2 Detector function selection and bandwidth

In radiated emissions measurement, a field strength meter that has a CISPR quasi-peak detector was used. The 6 dB bandwidth of the detector of instrument is 120 kHz over frequency range of 30 to 1000 MHz.

3.3 Method of Calculations

3.3.1 Unit of Conducted emission measurement

Conducted Emission Test results for conducted emissions are reported in micro-volts.

3.3.2 Unit of Radiated emission measurement

Test results of radiated emissions measurement are reported in micro-volts per meter at the specific distance. Using the unit of dBuV on the test instrument, the indication unit was converted to field strength unit of uV/m as following method;

$$F (uV/m) = 10^{\{(R+CL+AF)/20\}} (uV/m)$$

F: Field Strength in uV/m, R: Meter Reading Level in dB(uV),

CL: Cable Loss from antenna to meter in dB,

AF: Antenna Factor of receiving antenna in dB(/m)

Sample calculation (Radiated emission)

Emission level is calculated as follows;

Emission Level(dBuV/m)

= Reading Level + Ant. Factor + Cable Loss – Amp Gain

Margin Level is calculated as follows;

Margin(dBuV) = Limit Level – Emission Level

Example) Standard limit = 40 dBuV/m,

Reading Level = 10 dBuV,

Ant. Factor = 15 dB,

Cable Loss= 1 dB

External Amp Gain= 0 dB

Emission Level(dBuV/m) = 10 + 15 + 1 - 0 = 26 (dBuV/m)

Margin(dBuV) = 40 – 26 = 14 (dBuV)

4. Environments of measurement

4.1 Conditions of environment

Shield room	Temperature	33 °C
	Humidity	48 %
	Pressure	1011 hPa
OATS	Temperature	41 °C
	Humidity	55 %
	Pressure	1011 hPa

4.2 Measurement uncertainty

All measurements, especially EUT's measurement includes uncertain level that can happen for the reason as following;

Variation of antenna factor by changes of height, center, polarization, directivity.

Uncertainty factor by change of measurement distance, site's imperfection.

Radiated emissions measurements: ± 4 dB

Power line conducted emission measurements: ± 3 dB

The measurement uncertainty describes the overall uncertainty of the given measured value during the operation of the EUT in the above mentioned way.

The measurement uncertainty was calculated in accordance with NAMAS NIS 81 : The treatment of uncertainty in EMC measurement.”

The measurement uncertainty was given with a confidence of 95%.

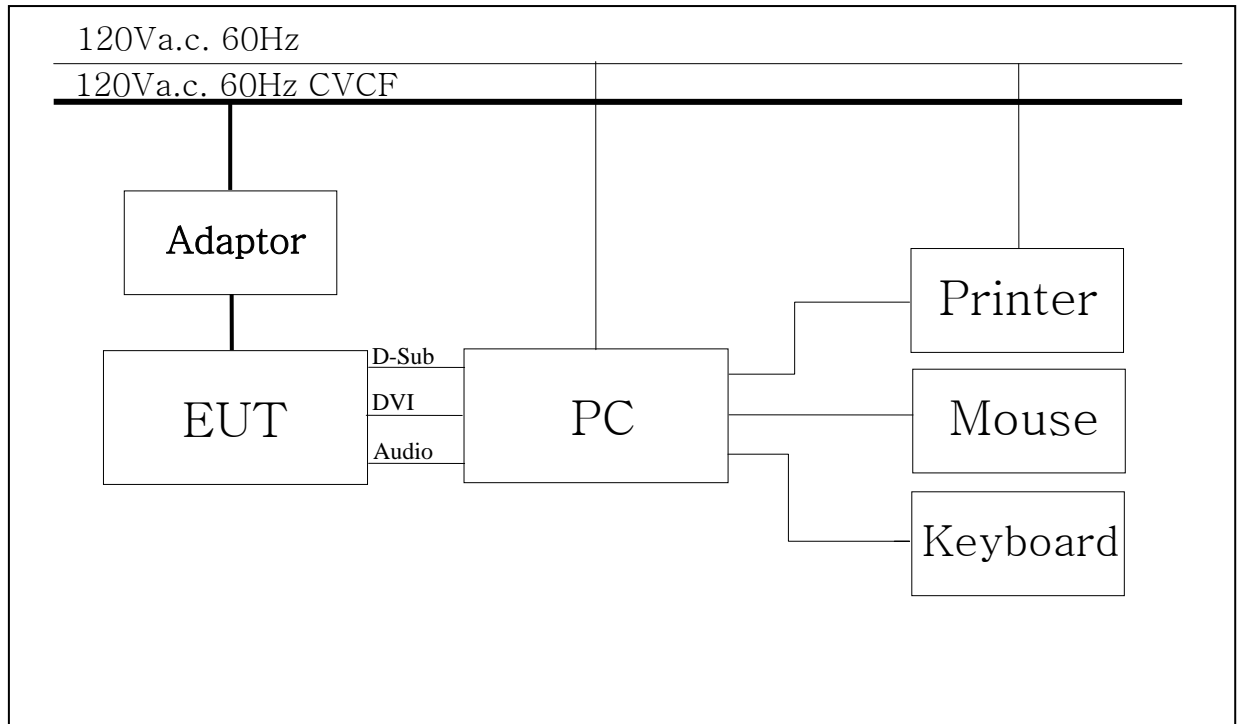
4.3 List of Test equipments

Used	Equipment	Maker	Model No.	S/No.	Cal.due date.
<input checked="" type="checkbox"/>	EMI Test Receiver	Rhode & Schwarz	ESIB7	100119	05/20/2006
<input checked="" type="checkbox"/>	Spectrum Analyzer	ADVANTEST	R3132	130300485	09/20/2005
<input type="checkbox"/>	Artificial Mains	Rhode & Schwarz	ESH2-Z5	100064	09/22/2005
<input checked="" type="checkbox"/>	Artificial Mains	Rhode & Schwarz	ESH3-Z5	100204	09/22/2005
<input type="checkbox"/>	Signal Generator	Rhode & Schwarz	SML03	101003	11/18/2005
<input type="checkbox"/>	Absorbing Clamp	Rhode & Schwarz	MDS-21	100076	09/21/2005
<input checked="" type="checkbox"/>	TRILOG Antenna	Schwarzbeck	VULB9163	164	05/16/2006
<input type="checkbox"/>	2 Wire ISN	Rhode & Schwarz	ENY22	10086	N/A
<input type="checkbox"/>	4 Wire ISN	Rhode & Schwarz	ENY41	100095	N/A
<input checked="" type="checkbox"/>	Pulse Limiter	Rhode & Schwarz	ESH3-Z2	100137	N/A
<input type="checkbox"/>	Attenuator	Rhode & Schwarz	DNF	100041	N/A
<input type="checkbox"/>	Attenuator	Rhode & Schwarz	MDS-2	100274	N/A
<input type="checkbox"/>	Ferrite Clamp	Rhode & Schwarz	EZ-24	100002	N/A

4.4 List of Peripherals & Cables

Used	Descriptions	Maker	Type	S/No.	Approval
<input checked="" type="checkbox"/>	Reference PC set	DELL	Dimension 4600	D39Z81S	Class B CE/FCC MIC/VCCI
<input checked="" type="checkbox"/>	Reference Printer	EPSON	P730A	60H0187628	
<input type="checkbox"/>	Reference Printer	HP	Deskjet 540	US52M1B0NF	
<input type="checkbox"/>	DC Power Supply	HP	6574A	US36340515	CE
<input checked="" type="checkbox"/>	M/W Cable/2GHz 5m	H+Suhner	SF104/2x11BNC	14354	
<input type="checkbox"/>	M/W Cable/2GHz10m	"	"	14353	
<input type="checkbox"/>	M/W Cable/18GHz18m	"	SF104/2x11N	6025	
<input checked="" type="checkbox"/>	M/W Cable/18GHz18m	"	"	6026	
<input type="checkbox"/>	M/W Cable/18GHz10m	"	"	6027	
<input checked="" type="checkbox"/>	M/W Cable/2GHz43m	Thermax	MS-P400		
<input type="checkbox"/>	Color monitor/composit	Samsung	SCM-14		
<input type="checkbox"/>	Function Generator	HP	3311A	1244A25104	
<input checked="" type="checkbox"/>	CCD Color Camera	Sung Eun	PSS-C5327		

4.5 Configuration of EUT



Used Peripherals

Descriptions	Maker	Type	S/No.	Remarks
EUT	DAYSYSYSTEM CO., LTD.	PL-177D	N/A	
Adapter	Dae Van Ent Co., Ltd.	DSA-0421S012 142	N/A	
Personal Computer	DELL	Dimension 4600	D39Z81S	
Printer	EPSON	Action 3250	60H0187628	
Mouse	DELL	MO56UD	337000527	
Key-board	DELL	SK-8100	3BH-1735	

5. Result of Measurement

5.1 Conducted Emission

5.1.1 Test data

Frequency [MHz]	Line	Limit[dBuV]		Result[dBuV]		Factor [dB]	Margin[dBuV]	
		QP	AV	QP	AV		QP	AV
D-Sub Mode								
0.420	L	57.45	47.45	40.60	39.68	10.87	16.85	7.77
0.480	L	56.34	46.34	44.58	40.63	10.87	11.76	5.71
0.540	L	56.00	46.00	45.48	40.08	10.90	10.52	5.92
0.600	L	56.00	46.00	40.66	38.45	10.91	15.34	7.55
DVI Mode								
0.150	N	66.00	56.00	36.75	29.29	10.84	29.25	26.71
0.175	N	64.72	54.72	34.80	27.13	10.85	29.92	27.59
0.420	L	57.45	47.45	40.61	39.81	10.87	16.84	7.64
0.480	L	56.34	46.34	44.73	39.83	10.88	11.61	6.51
0.540	L	56.00	46.00	45.76	41.40	10.90	10.24	4.60
0.600	L	56.00	46.00	40.96	38.90	10.91	15.04	7.10

* Detector function was set into Quasi-peak & Average mode.

* Factor = LISN Factor + Cable loss + Pulse Limiter

5.1.2 Result

Complied

5.2 Radiated Emission

5.2.1 Test data

Frequency [MHz]	Polarization [Ver/Hor]	Limit [dBuV/m]	Result [dBuV/m]	Factor [dB]	Margin [dBuV/m]
D-Sub Mode					
244.85	V	46.00	41.88	14.37	4.12
264.10	V	46.00	38.20	14.97	7.80
306.15	V	46.00	41.99	16.03	4.01
548.35	V	46.00	41.73	21.58	4.27
670.20	H	46.00	40.53	23.95	5.47
796.00	V	46.00	38.37	25.43	7.63
913.85	V	46.00	28.90	27.05	17.10
979.85	V	53.90	41.86	27.68	12.04
DVI Mode					
243.75	V	46.00	41.64	14.33	4.36
304.65	V	46.00	41.84	15.98	4.16
432.00	V	46.00	41.26	19.13	4.74
600.05	V	46.00	41.54	23.16	4.46
795.65	V	46.00	39.21	25.43	6.79
974.75	V	53.90	42.58	27.60	11.32

* Detector function was set into Quasi-peak mode.

* Factor = Antenna factor + Cable loss

* External Amp Gain : 0 dB

5.2.1 Result

Complied

6. Attachments

6.1 Sample Label

DAYSYSTEM CO., LTD.

17" TFT LCD Monitor

MODEL : DS174

POWER : 12Vd.c.

FCC ID. : xxxDS174

THIS DEVICE COMPLIES WITH PART 15 OF THE FCC RULES.
OPERATION IS SUBJECT TO THE FOLLOWING TWO CONDITIONS :
(1) THIS DEVICE MAY NOT CAUSE HARMFUL INTERFERENCE, AND
(2) THIS DEVICE MUST ACCEPT ANY INTERFERENCE RECEIVED
INCLUDING INTERFERENCE THAT MAY CAUSE UNDESIRE
OPERATION

Made In Korea

Labeling Requirements per section 2.925 & 15.19

The label shown shall be permanently affixed at a conspicuous location on the device and be readily visible to the user at the time of purchase.



6.2 Photographs of Set-up

Conducted emission test (Front)



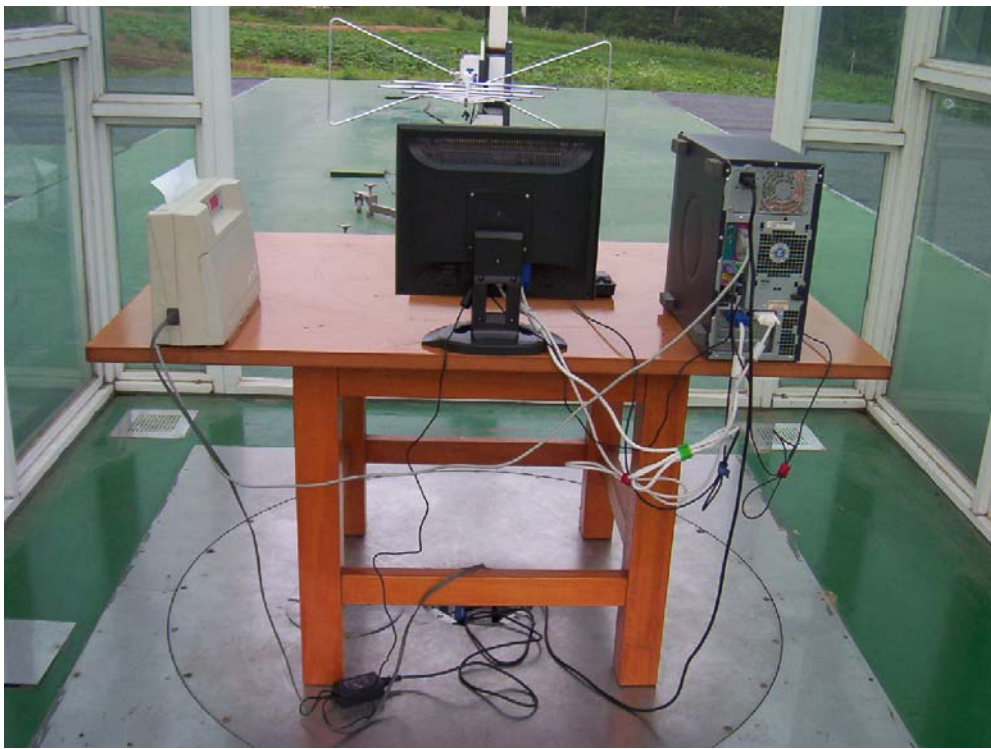
Conducted emission test (Rear)



Radiated Emission (Front)

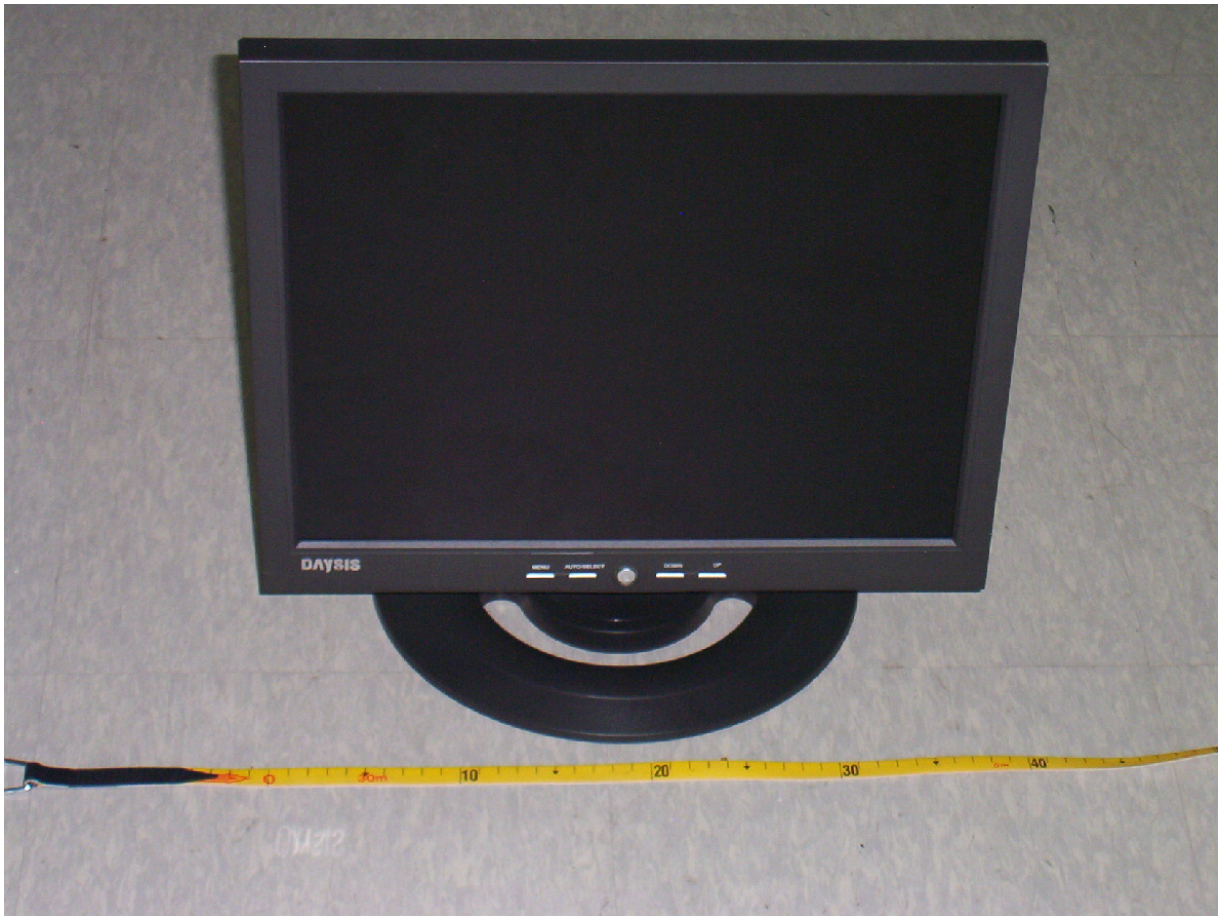


Radiated Emission (Rear)



6.3 Photographs of EUT

Front View



Rear View



Side view

